

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/087,824	YAMAGUCHI ET AL.	
Examiner	Art Unit	
LUONG T. NGUYEN	2622	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
348/296,300-304,308 (text search only see search history printout	3/5/2006	LN		
EAST (USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB)	3/5/2006	LN		
348/294-332; 257/E27.131,435 (text search only see search history printout	8/18/2006	LN		
EAST (USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB)	8/18/2006	LN		
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